

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application of: Richard William CHARM et al.

Confirmation No: 6496

Serial No.:

10/689,657

Art Unit:

To be Assigned

Filed:

October 22, 2003

Examiner:

To be Assigned

For:

PROCESS FOR THE USE OF BIS-

Atty Docket No: 060937-0139-US

CHOLINE AND TRIS-CHOLINE IN THE

**CLEANING OF QUARTZ-COATED** 

POLYSILICON AND OTHER MATERIALS

## INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Pursuant to applicants' duty of disclosure under 37C.F.R. 1.56, attached is a PTO-1449 citing the thirty-nine (39) references noted in the application for the Examiner's consideration. Copies of the foreign references are enclosed for the Office's convenience (U.S. references are not submitted herewith as this application was filed after June 1, 2003).

No additional fees are believed due, however, should it be deemed fees or credits are due in this matter, the Examiner is authorized to charge/credit Morgan, Lewis & Bockius LLP Deposit Account No. 50-0310.

Respectfully submitted,

Date:

March 2, 2004

Christopher 6. Hayden

Reg., No. 44,750

Morgan, Lewis & Bockius LLP 1111 Pennsylvania Avenue, N.W.

Washington, D.C. 20004

(202) 739-3000

					ATTY DOCKET NO. 060937-0139		APPLICATIO 10/689,65	
LIST OF R	EFER	RENCES CITED BY (Use several sheets if no	APPLICA eccessary)	NT	APPLICANT Richard William	CHARM	I et al.	
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	A01							
	A02							
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			FOREIG	N PATENT DOCUMENTS				
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSL	ATION
			T	-1-			YES	NO
	B01	64-42653	01/1989	Japan				
	B02	64-81949	03/1989	Japan				
	B03	62-2813232	12/1987	Japan				
	B04	63-208043	08/1988	. Japan				
	B05	11-197523	07/1999	Japan				
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	B07	6-163495	06/1994	Japan				
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	B14	1-191450	08/1989	Japan				
	B15							
	B16						-	
	B17							

	OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)
C01	

EXAMINER	DATE CONSIDERED
*EXAMINER: Initial if reference considered, whether or not citation is in conformar considered. Include copy of this form with next communication to applicant.	nce with MPEP 609; Draw line through citation if not in conformance and not

ATTY DOCKET NO. APPLICATION NO 10/689,657 060937-0139 REFERENCES CITED BY APPLICANT APPLICANT (Use several sheets if necessary) Richard William CHARM et al. FILING DATE GROUP MAR 0 2 2004 October 22, 2003 To be Assigned TRADEMA

## **U.S. PATENT DOCUMENTS**

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	A01	4,403,028	09/1983	Ward, Jr. et al.			
	A02	4,172,005	10/1979	Muraoka et al.			
	A03	4,239,661	12/1980	Muraoka et al.			•
	A04	4,294,911	10/1981	Guild			
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	A06	4,395,479	07/1983	Ward et al.			
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	A15	5,102,777	04/1992	Lin et al.			
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	A20	5,417,802	05/1995	Obeng			
	A21	5,480,585	01/1996	Shiotsu et al.			
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	A25	5,846,695	12/1998	Iwata et al.			
	A26						
	A27						

EXAMINER DATE CONSIDERED
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<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.